Application/Control No. Applicant(s)/Patent Under Reexamination 10/708,679 LU ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Christopher P. Schwartz 3683 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-4,917,444 04-1990 Ishido et al. 303/146 Α US-В US-С US-D US-Ε US-F US-G USн US-US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY N 0 Р Q R S Т **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	8	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.